

**Notice of References Cited**

Application/Control No.

10/593,514

Applicant(s)/Patent Under  
Reexamination  
MATSUI ET AL.

Examiner

Janet L. Epps-Smith

Art Unit

1633

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,504,383	03-2009	Gazit et al.	514/19
*	C	US-2007/0276131	11-2007	Ferre et al.	530/420
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X	N	WO 2005019263 A1	03-2005	World Intellect	FERRE et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lee et al. (Feb. 2004; Other Condensed Matter: <a href="http://arxiv.org/abs/cond-mat/0402204">http://arxiv.org/abs/cond-mat/0402204</a> ).
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	W	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.